

**Search Notes**

Application/Control No.

10/763,010

Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

BREITSCHWERDT ET AL.

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
438	711	3/15/2006	BT
438	728	3/15/2006	BT
438	732	3/15/2006	BT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
438	711	3/15/2006	BT
438	728	3/15/2006	BT
438	732	3/15/2006	BT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search keywords and inventor's name using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	3/15/2006	BT